

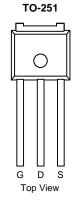
SW4N70L-VB TO251 Datasheet N-Channel 700V (D-S) Super Junction Power MOSFET

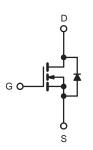
PRODUCT SUMMARY				
V _{DS} (V)	700			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V 1.1			
Q _g (Max.) (nC)	15			
Q _{gs} (nC)	3			
Q _{gd} (nC)	6			
Configuration	Single			

FEATURES



- ullet Low Gate Charge $\mathbf{Q}_{\mathbf{g}}$ Results in Simple Drive Requirement
- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Compliant to RoHS directive 2002/95/EC





N-Channel MOSFET

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V_{DS}	700	V	
Gate-Source Voltage		V_{GS}	± 30	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	
Continuous Drain Current ^e	V_{GS} at 10 V $T_C = 25 ^{\circ}\text{C}$		5		
Continuous Drain Current	$T_C = 100 ^{\circ}$ C	l _D	4	Α	
Pulsed Drain Current ^a	I _{DM}	16			
Linear Derating Factor		1.67/0.8/0.3	W/°C		
Single Pulse Avalanche Energy ^b	E _{AS}	120	mJ		
Repetitive Avalanche Current ^a	I _{AR}	34	Α		
Repetitive Avalanche Energy ^a	E _{AR}	17	mJ		
aximum Power Dissipation $T_C = 25 ^{\circ}C$		P_{D}	205/35/30	W	
Peak Diode Recovery dV/dtc	dV/dt	4.5	V/ns		
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature) ^d for 10 s			300		
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
Mounting Torque	0-32 of M3 Screw		1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T $_J$ = 25 °C, L = 24 mH, R $_G$ = 25 Ω , I $_{AS}$ = 3.2 A (see fig. 12). c. I $_{SD}$ ≤ 3.2 A, dl/dt ≤ 90 A/ μ s, V $_{DD}$ ≤ V $_{DS}$, T $_J$ ≤ 150 °C.

- d. 1.6 mm from case.
- e. Drain current limited by maximum junction temperature.



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.6/1.2/0.6	C/VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 250 μA	700	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = 1 mA ^d	-	0.6	-	mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 30 V		-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		= 700 V, V _{GS} = 0 V V, V _{GS} = 0 V, T _J = 125 °C	-	-	10 100	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 2.5 A ^b	-	1.1	-	Ω
Forward Transconductance	9 _{fs}	V _{DS}	= 50 V, I _D = 2.5 A	8	-	-	S
Dynamic					<u>'</u>		
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	320	-	
Output Capacitance	C _{oss}	1	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		75	-	1
Reverse Transfer Capacitance	C _{rss}	f = 1			4	-	ne.
Output Capacitance	Coss		V _{DS} = 1.0 V, f = 1.0 MHz	-	500	-	- pF -
			V _{DS} = 520 V, f = 1.0 MHz	-	83	-	
Effective Output Capacitance	C _{oss} eff.		V _{DS} = 0 V to 520 V ^c	-	14	-	
Total Gate Charge	Q_g			-	-	15	nC
Gate-Source Charge	Q_{gs}	V _{GS} = 10 V	$I_D = 2.5 \text{ A}, V_{DS} = 400 \text{ V}$	-	-	3	
Gate-Drain Charge	Q_{gd}		see fig. 6 and 13 ^b		-	6	1
Turn-On Delay Time	t _{d(on)}		1		18	-	
Rise Time	t _r		= 325 V, I _D = 3.2 A	-	40	-	
Turn-Off Delay Time	t _{d(off)}	$R_G = 9.1 \Omega$, $R_D = 62 \Omega$, see fig. 10^b		-	50	-	ns
Fall Time	t _f			ı	30	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	showing the	/ : T/		-	5	A
Pulsed Diode Forward Current ^a	I _{SM}	p - n junction diode		ı	-	16	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 3.2 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = 3.2 A, dI/dt = 100 A/μs ^b		ı	180	-	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	2.1	3.2	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by $L_{\mbox{\scriptsize S}}$ and $L_{\mbox{\scriptsize D}}$)				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.
- c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .
- d. t = 60 s, f = 60 Hz.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

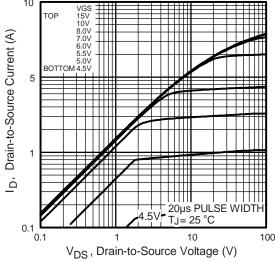


Fig. 1 - Typical Output Characteristics

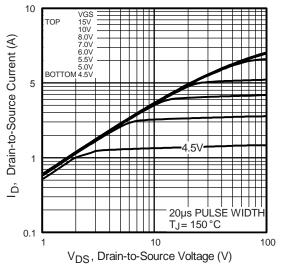


Fig. 2 - Typical Output Characteristics

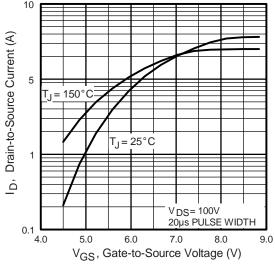


Fig. 3 - Typical Transfer Characteristics

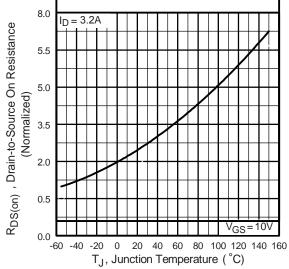


Fig. 4 - Normalized On-Resistance vs. Temperature



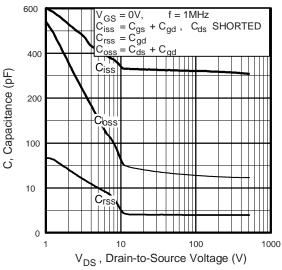


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

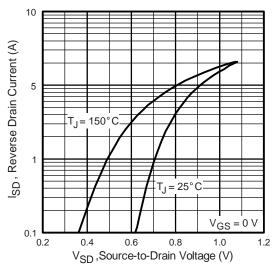


Fig. 7 - Typical Source-Drain Diode Forward Voltage

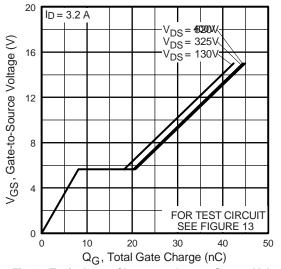


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

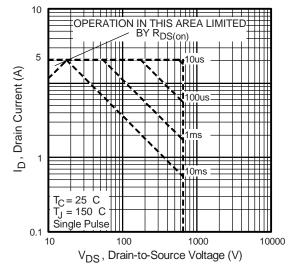


Fig. 8 - Maximum Safe Operating Area



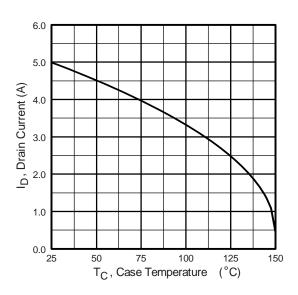


Fig. 9 - Maximum Drain Current vs. Case Temperature

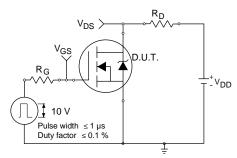


Fig. 10a - Switching Time Test Circuit

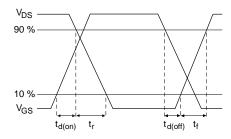


Fig. 10b - Switching Time Waveforms

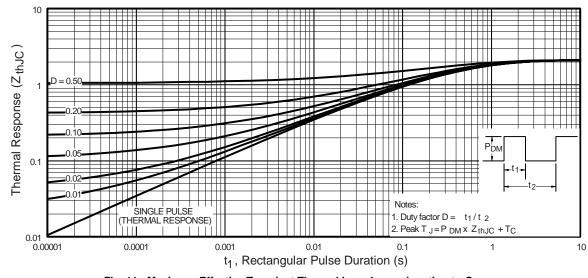


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

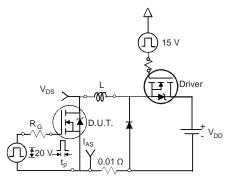


Fig. 12a - Unclamped Inductive Test Circuit

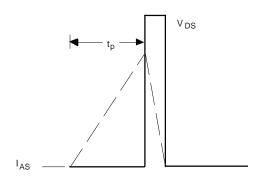


Fig. 12b - Unclamped Inductive Waveforms



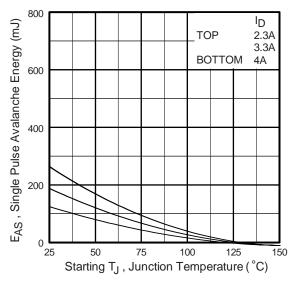


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

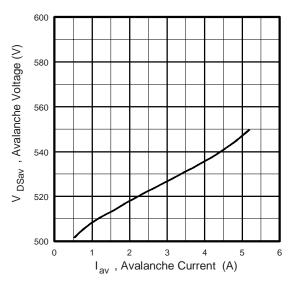


Fig. 12d - Typical Drain-to Source Voltage vs. Avalanche Current

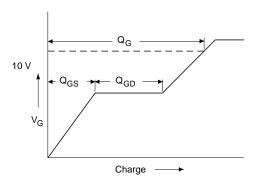


Fig. 13a - Basic Gate Charge Waveform

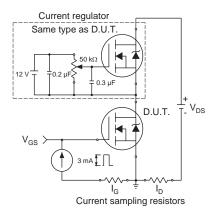
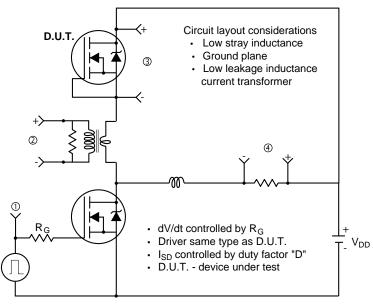


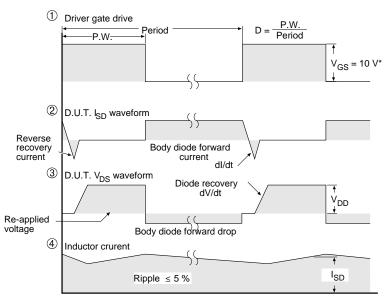
Fig. 13b - Gate Charge Test Circuit



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Peak Diode Recovery dV/dt Test Circuit



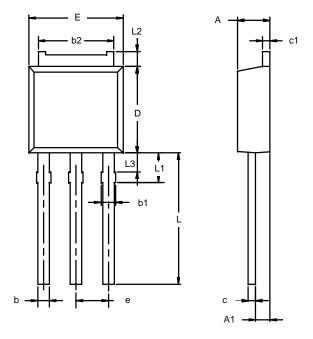


* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel



TO-251AA (DPAK)



Note: Dimension L3	is for reference only.
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	MILLIM	IETERS	INC	HES	
Dim	Min	Max	Min	Max	
Α	2.21	2.38	0.087	0.094	
A1	0.89	1.14	0.035	0.045	
b	0.71	0.89	0.028	0.035	
b1	0.76	1.14	0.030	0.045	
b2	5.23	5.43	0.206	0.214	
С	0.46	0.58	0.018	0.023	
с1	0.46	0.58	0.018	0.023	
D	5.97	6.22	0.235	0.245	
E	6.48	6.73	0.255	0.265	
е	2.28 BSC		0.090	BSC	
L	8.89	9.53	0.350	0.375	
L1	1.91	2.28	0.075	0.090	
L2	0.89	1.27	0.035	0.050	
L3	1.15	1.52	0.045	0.060	
ECN: S-03946—Rev. E, 09-Jul-01 DWG: 5346					



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